


<b>Search Notes</b>  	<b>Application/Control No.</b>  10599160	<b>Applicant(s)/Patent Under Reexamination</b>  HABETHA ET AL.
	<b>Examiner</b>  Michael Mapa	<b>Art Unit</b>  2617

SEARCHED			
Class	Subclass	Date	Examiner
370	337, 321-324	09/19/09	/MM/
455	450, 41.2	09/19/09	/MM/

SEARCH NOTES			
Search Notes		Date	Examiner
INVENTOR SEARCH		09/19/09	/MM/
PLUS SEARCH		09/19/09	/MM/
EAST SEARCH		09/19/09	/MM/

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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